

INTERNATIONAL STANDARD

NORME INTERNATIONALE

**Ferrite cores – Guide on the limits of surface irregularities –
Part 5: Planar-cores**

**Noyaux de ferrite – Guide relatif aux limites des irrégularités de surface –
Partie 5: Noyaux planaires**



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INTERNATIONAL ELECTROTECHNICAL COMMISSION

FERRITE CORES – GUIDE ON THE LIMITS OF SURFACE IRREGULARITIES –

Part 5: Planar-cores

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International Standard IEC 60424-5 has been prepared by IEC technical committee 51: Magnetic components and ferrite materials.

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The text of this standard is based on the following documents:

FDIS	Report on voting
51/947/FDIS	51/950/RVD

Full information on the voting for the approval of this standard can be found in the report on voting indicated in the above table.

The French version of this standard has not been voted upon.

This publication has been drafted in accordance with the ISO/IEC Directives, Part 2.

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